

SINGLE-CELL LI-ION CHARGE MANAGEMENT IC FOR PDAs AND INTERNET APPLIANCES

FEATURES

- **Highly Integrated Solution With FET Pass Transistor and Reverse-Blocking Schottky and Thermal Protection**
- **Integrated Voltage and Current Regulation With Programmable Charge Current**
- **High-Accuracy Voltage Regulation ($\pm 1\%$)**
- **Ideal for Low-Dropout Linear Charger Designs for Single-Cell Li-Ion Packs With Coke or Graphite Anodes**
- **Up to 1.2-A Continuous Charge Current**
- **Safety-Charge Timer During Preconditioning and Fast Charge**
- **Integrated Cell Conditioning for Reviving Deeply Discharged Cells and Minimizing Heat Dissipation During Initial Stage of Charge**
- **Optional Temperature or Input-Power Monitoring Before and During Charge**
- **Various Charge-Status Output Options for Driving Single, Double, or Bicolor LEDs or Host-Processor Interface**
- **Charge Termination by Minimum Current and Time**
- **Low-Power Sleep Mode**
- **Packaging: 5 mm \times 5 mm MLP or 20-Lead TSSOP PowerPAD™**

APPLICATIONS

- **PDAs**
- **Internet Appliances**
- **MP3 Players**
- **Digital Cameras**

DESCRIPTION

The bq2400x series ICs are advanced Li-Ion linear charge management devices for highly integrated and space-limited applications. They combine high-accuracy current and voltage regulation; FET pass-transistor and reverse-blocking Schottky; battery conditioning, temperature, or input-power monitoring; charge termination; charge-status indication; and charge timer in a small package.

The bq2400x measures battery temperature using an external thermistor. For safety reasons, the bq2400x inhibits charge until the battery temperature is within the user-defined thresholds. Alternatively, the user can monitor the input voltage to qualify charge. The bq2400x series then charge the battery in three phases: preconditioning, constant current, and constant voltage. If the battery voltage is below the internal low-voltage threshold, the bq2400x uses low-current precharge to condition the battery. A preconditioning timer is provided for additional safety. Following preconditioning, the bq2400x applies a constant-charge current to the battery. An external sense-resistor sets the magnitude of the current. The constant-current phase is maintained until the battery reaches the charge-regulation voltage. The bq2400x then transitions to the constant voltage phase. The user can configure the device for cells with either coke or graphite anodes. The accuracy of the voltage regulation is better than $\pm 1\%$ over the operating junction temperature and supply voltage range.

Charge is terminated by maximum time or minimum taper current detection

The bq2400x automatically restarts the charge if the battery voltage falls below an internal recharge threshold.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PowerPAD is a trademark of Texas Instruments.



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

ORDERING INFORMATION

T _J	PACKAGE		CHARGE STATUS CONFIGURATION
	20-LEAD HTTSOP PowerPAD™ (PWP)(1)	20-LEAD 5 mm × 5 mm MLP (RGW)(2)	
–40°C to 125°C	bq24001PWP	bq24001RGW	Single LED
	bq24002PWP	bq24002RGW	2 LEDs
	bq24003PWP	bq24003RGW	Single bicolor LED

(1) The PWP package is available taped and reeled. Add R suffix to device type (e.g. bq24001PWPR) to order. Quantities 2500 devices per reel.

(2) The RGW package is available taped and reeled. Add R suffix to device type (e.g. bq24001RGWR) to order. Quantities 3000 devices per reel.

PACKAGE DISSIPATION RATINGS

PACKAGE	θ _{JA}	θ _{JC}	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C
PWP(1)	30.88°C/W	1.19°C/W	3.238 W	0.0324W/°C
RGW(2)	31.41°C/W	1.25°C/W	3.183 W	0.0318W/°C

(1) This data is based on using the JEDEC high-K board and topside traces, top and bottom thermal pad (6.5 × 3.4 mm), internal 1 oz power and ground planes, 8 thermal via underneath the die connecting to ground plane.

(2) This data is based on using the JEDEC high-K board and topside traces, top and bottom thermal pad (3.25 × 3.25 mm), internal 1 oz power and ground planes, 9 thermal via underneath the die connecting to ground plane.

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range unless otherwise noted⁽¹⁾

	bq24001 bq24002 bq24003
Supply voltage (V _{CC} with respect to GND)	13.5 V
Input voltage (IN, ISNS, EN, APG/THERM/CR/STAT1/STAT2, VSENSE, TMR SEL, VSEL) (all with respect to GND)	13.5 V
Output current (OUT pins)	2 A
Output sink/source current (STAT1 and STAT2)	10 mA
Operating free-air temperature range, T _A	–40°C to 70°C
Storage temperature range, T _{stg}	–65°C to 150°C
Junction temperature range, T _J	–40°C to 125°C
Lead temperature (Soldering, 10 sec)	300°C

(1) Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

RECOMMENDED OPERATING CONDITIONS

	MIN	MAX	UNIT
Supply voltage, V _{CC}	4.5	10	V
Input voltage, V _{IN}	4.5	10	V
Continuous output current		1.2	A
Operating junction temperature range, T _J	–40	125	°C

ELECTRICAL CHARACTERISTICS

over recommended operating junction temperature supply and input voltages, and $V_I (V_{CC}) \geq V_I (IN)$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
V_{CC} current	$V_{CC} > V_{CC_UVLO}$, $EN \leq V_{IH}(EN)$			1	mA
V_{CC} current, standby mode	$EN \leq V_{IL}(EN)$		1		μ A
IN current, standby mode	$EN \leq V_{IL}(EN)$			10	μ A
Standby current (sum of currents into OUT and VSENSE pins)	$V_{CC} < V_{CC_UVLO}$, $V_{OUT} = 4.3$ V, $V_{SENSE} = 4.3$ V		2	4	μ A
	$EN \leq V_{IL}(EN)$, $V_{OUT} = 4.3$ V, $V_{SENSE} = 4.3$ V		2	4	

VOLTAGE REGULATION, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage	$V_{SEL} = V_{SS}$, $0 < I_O \leq 1.2$ A	4.059	4.10	4.141	V
	$V_{SEL} = V_{CC}$, $0 < I_O \leq 1.2$ A	4.158	4.20	4.242	V
Load regulation	$1 \text{ mA} \leq I_O \leq 1.2$ A, $V_{CC} = 5$ V, $V_I(IN) = 5$ V, $T_J = 25^\circ\text{C}$		1		mV
Line regulation	$V_{OUT} + V_{DO} + V_{ilim}(MAX) < V_I(V_{CC}) < 10$ V, $T_J = 25^\circ\text{C}$		0.01		%/V
Dropout voltage = $V_I(IN) - V_{out}$	$I_O = 1.0$ A, $4.9 \text{ V} < V_I(V_{CC}) < 10$ V			0.7	V
	$I_O = 1.2$ A, $V_{OUT} + V_{DO} + V_{ilim}MAX < V_I(V_{CC}) < 10$ V			0.8	V

CURRENT REGULATION, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Current regulation threshold, $V_I(\text{limit})$	$V_{SENSE} < V_O(V_{SEL-LOW/HIGH})$	0.095	0.1	0.105	V
Delay time	V_{SENSE} pulsed above V_{LOWV} to $I_O = 10\%$ of regulated value ⁽¹⁾			1	ms
Rise time	I_O increasing from 10% to 90% of regulated value. $R_{SNS} \geq 0.2 \Omega$, (1)	0.1		1	ms

(1) Specified by design, not production tested.

CURRENT SENSE RESISTOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
External current sense resistor range (R_{SNS})	$100 \text{ mA} \leq I_{lim} \leq 1.2$ A	0.083		1	Ω

PRECHARGE CURRENT REGULATION, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Precharge current regulation	$V_{SENSE} < V_{LOWV}$, $0.083 \leq R_{SNS} \leq 1.0 \Omega$	40	60	80	mA

V_{CC} UVLO COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start threshold		4.35	4.43	4.50	V
Stop threshold		4.25	4.33	4.40	V
Hysteresis		50			mV

APG/THERM COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Upper trip threshold		1.480	1.498	1.515	V
Lower trip threshold		0.545	0.558	0.570	V
Input bias current				1	μ A

LOWV COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Start threshold		2.80	2.90	3.00	V
Stop threshold		3.00	3.10	3.20	V
Hysteresis		100			mV

ELECTRICAL CHARACTERISTICS CONTINUED

over recommended operating junction temperature supply and input voltages, and $V_I (V_{CC}) \geq V_I (IN)$ (unless otherwise noted)

HIGHV (RECHARGE) COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Start threshold		3.80	3.90	4.00	V	

OVERV COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Start threshold		4.35	4.45	4.55	V	
Stop threshold		4.25	4.30	4.35	V	
Hysteresis		50			mV	

TAPERDET COMPARATOR, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Trip threshold		12	18.5	25	mV	

EN LOGIC INPUT, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
High-level input voltage		2.25			V	
Low-level input voltage				0.8	V	
Input pull-down resistance		100		200	k Ω	

VSEL LOGIC INPUT, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
High-level input voltage		2.25			V	
Low-level input voltage				0.8	V	
Input pull-down resistance		100		200	k Ω	

TMR SEL INPUT $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
High-level input voltage		2.7			V	
Low-level input voltage				0.6	V	
Input bias current	$V_I(\text{TMR SEL}) \leq 5\text{V}$			15	μA	

STAT1, STAT2 (bq24001, bq24003), $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
Output (low) saturation voltage	$I_O = 10\text{ mA}$			1.5	V	
Output (low) saturation voltage	$I_O = 4\text{ mA}$			0.6	V	
Output (high) saturation voltage	$I_O = -10\text{ mA}$	$V_{CC}-1.5$			V	
Output (high) saturation voltage	$I_O = -4\text{ mA}$	$V_{CC}-0.5$			V	
Output turn on/off time	$I_O = \pm 10\text{ mA}, C = 100\text{ p}^{(1)}$			100	μs	

(1) Assured by design, not production tested.

POWER-ON RESET (POR), $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$						
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
POR delay	See Note 1	1.2		3	ms	
POR falling-edge deglitch	See Note 1	25		75	μs	

(1) Assured by design, not production tested.

ELECTRICAL CHARACTERISTICS CONTINUED

over recommended operating junction temperature supply and input voltages, and $V_I (V_{CC}) \geq V_I (IN)$ (unless otherwise noted)

APG/THERM DELAY, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
APG/THERM falling-edge deglitch	See Note 1	25		75	μs

(1) Assured by design, not production tested.

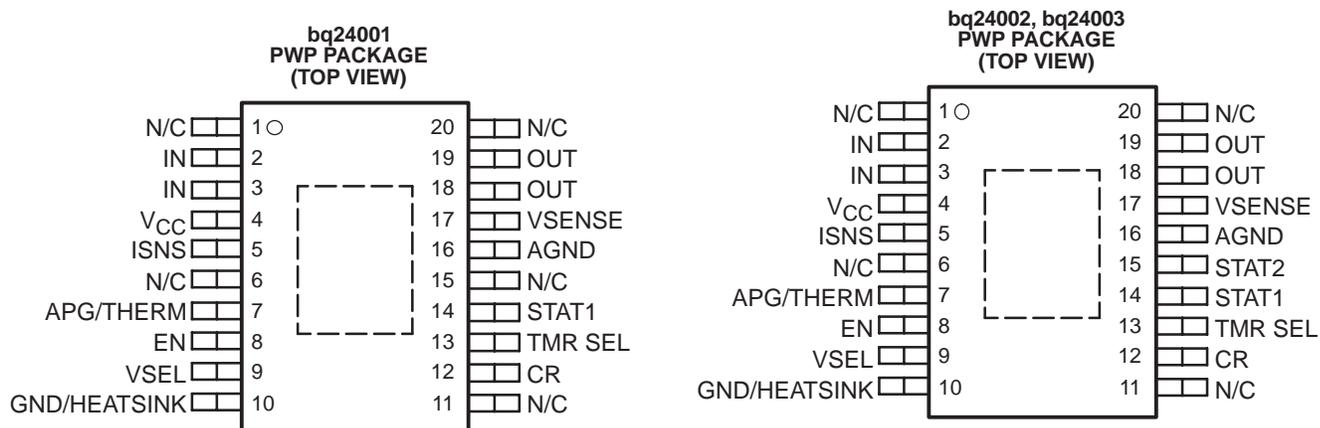
TIMERS, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
User-selectable timer accuracy	$T_A = 25^\circ\text{C}$	-15%		15%	
		-20%		20%	
Precharge and taper timer			22.5		minute

THERMAL SHUTDOWN, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Thermal trip	See Note 1		165		$^\circ\text{C}$
Thermal hysteresis	See Note 1		10		$^\circ\text{C}$

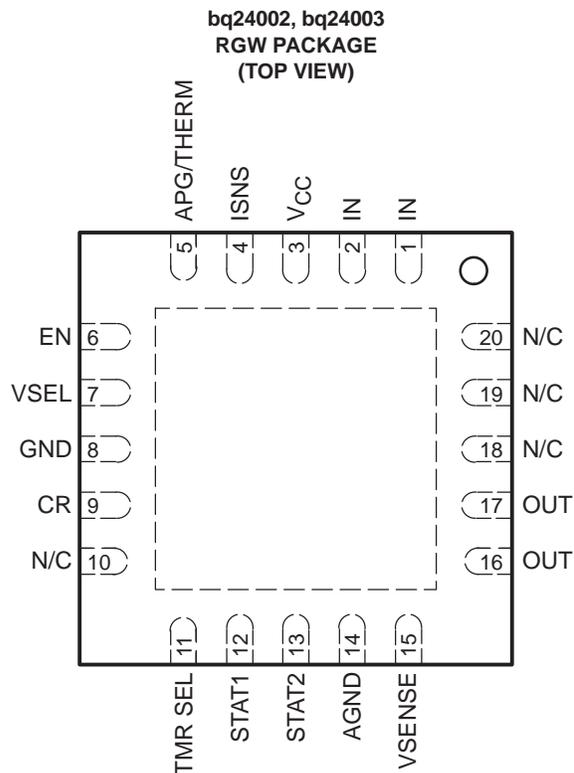
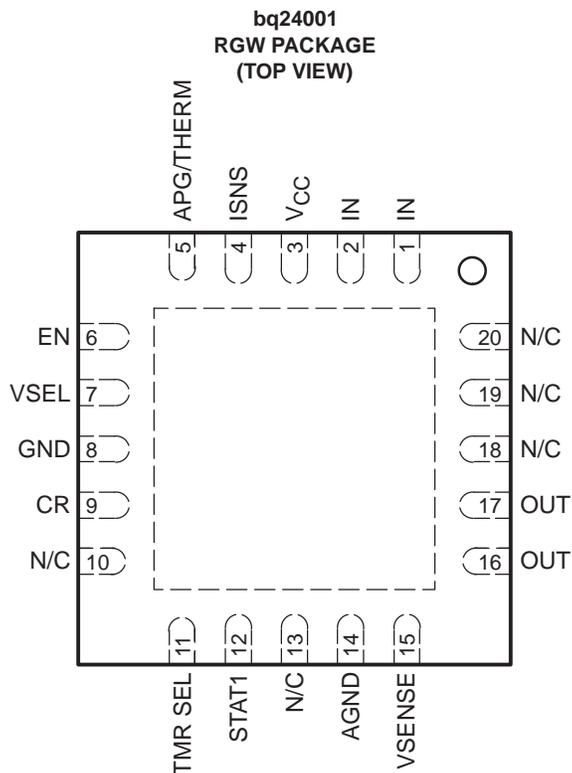
(1) Assured by design, not production tested.

CR PIN, $0^\circ\text{C} \leq T_J \leq 125^\circ\text{C}$					
PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Output voltage	$0 < I_{O(CR)} < 100 \mu\text{A}$	2,816	2.85	2.88	V

PIN ASSIGNMENTS



N/C – Do not connect

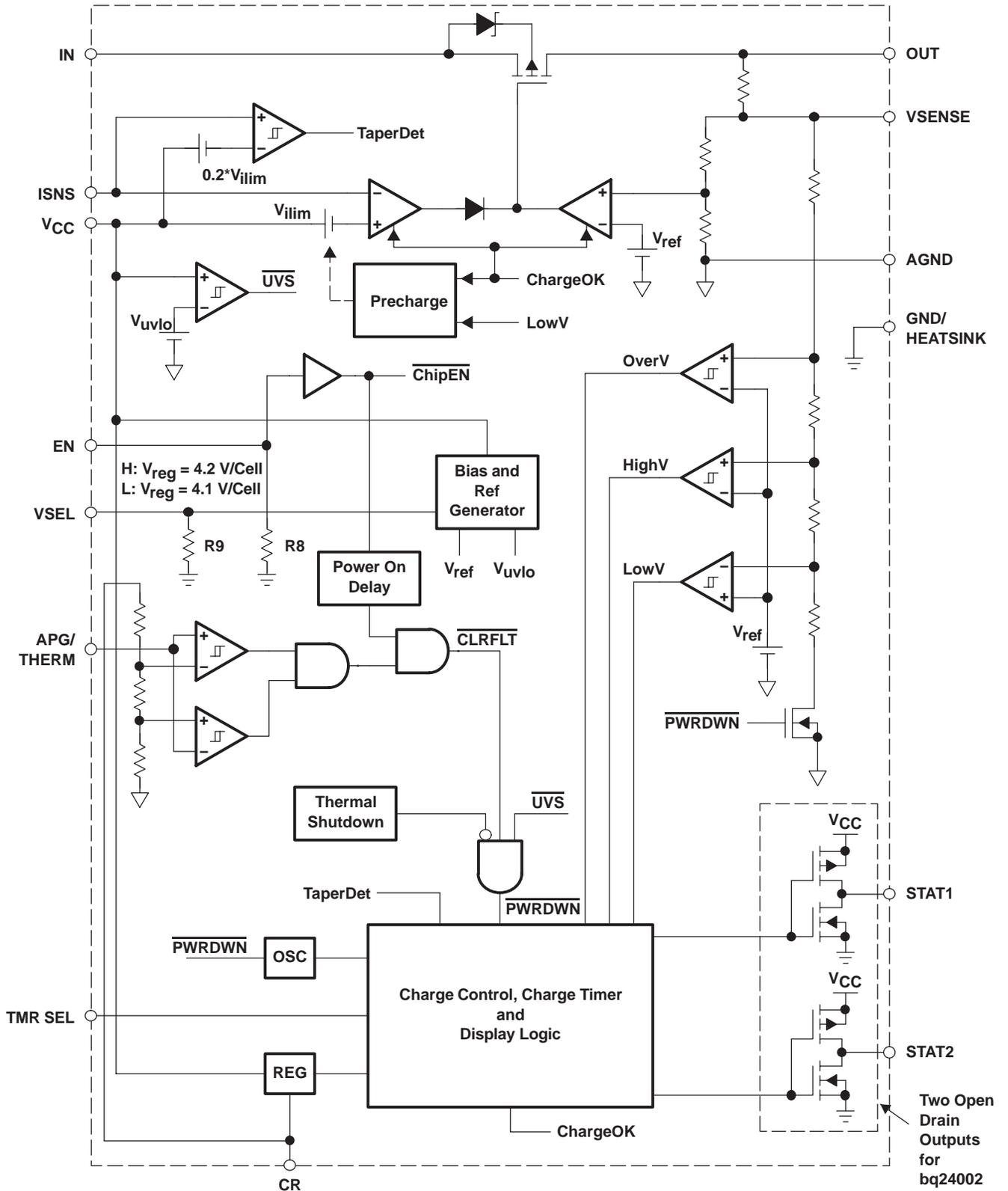


N/C – Do Not Connect

Terminal Functions

TERMINAL			I/O	DESCRIPTION
NAME	NO.	NO.		
AGND	16	14		Ground pin; connect close to the negative battery terminal.
APG/THERM	7	5	I	Adapter power good input/thermistor sense input
CR	12	9	I	Internal regulator bypass capacitor
EN	8	6	I	Charge-enable input. Active-high enable input with internal pull down. Low-current stand-by mode active when EN is low.
GND/HEATSINK	10	8		Ground pin; connect to PowerPAD heat-sink layout pattern.
IN	2, 3	1, 2	I	Input voltage. This input provides the charging voltage for the battery.
ISNS	5	4	I	Current sense input
N/C	1, 6, 11, 15, 20	10, 13, 18–20		No connect. These pins must be left floating. Pin 15 is N/C on bq24001PWP only. Pin 13 is N/C on bq24001RGW only.
OUT	18, 19	16, 17	O	Charge current output
STAT1	14	12	O	Status display output 1
STAT2	15	13	O	Status display output 2 (for bq24002 and bq24003 only)
TMR SEL	13	11	I	Charge timer selection input
VCC	4	3	I	Supply voltage
VSEL	9	7	I	4.1 V or 4.2 V charge regulation selection input
VSENSE	17	15	I	Battery voltage sense input

FUNCTIONAL BLOCK DIAGRAM



TYPICAL CHARACTERISTICS

OUTPUT VOLTAGE
vs
OUTPUT CURRENT

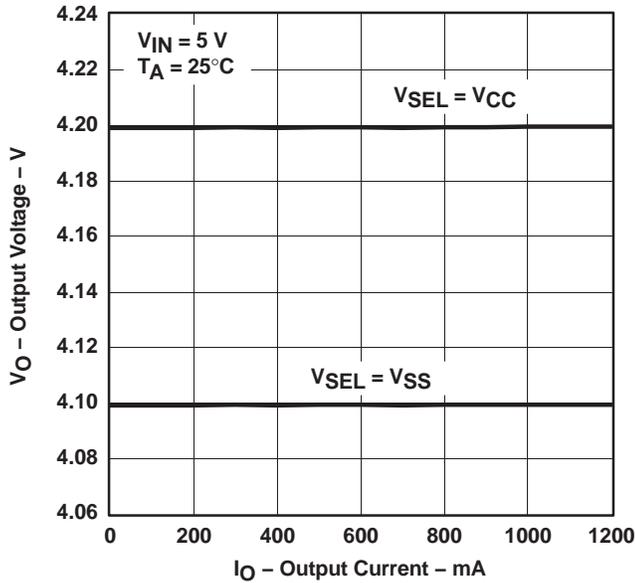


Figure 1

OUTPUT VOLTAGE
vs
JUNCTION TEMPERATURE

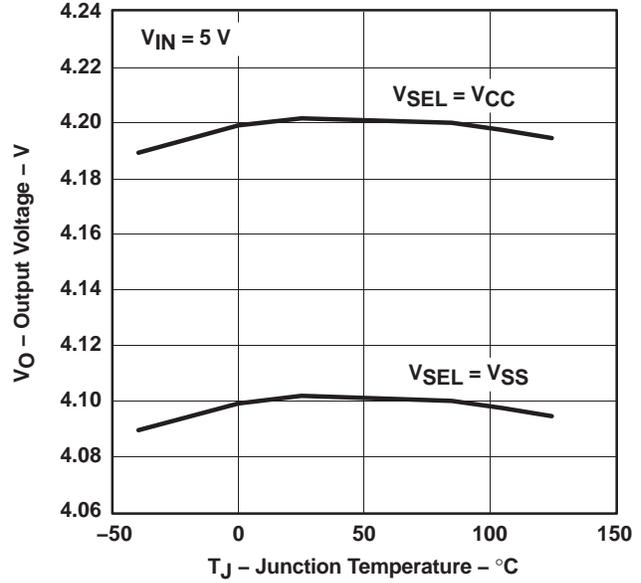


Figure 2

OUTPUT VOLTAGE
vs
INPUT VOLTAGE

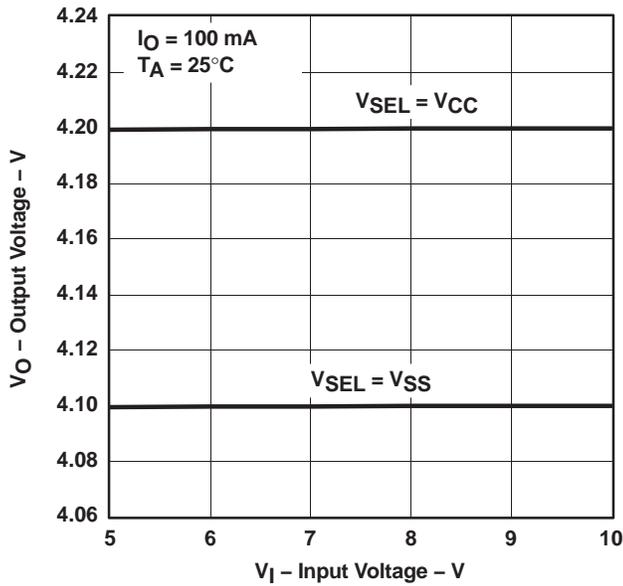


Figure 3

CURRENT SENSE VOLTAGE
vs
INPUT VOLTAGE

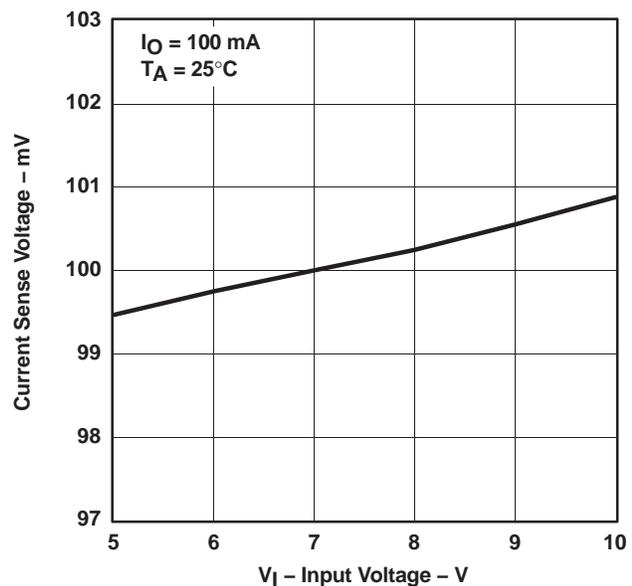


Figure 4

TYPICAL CHARACTERISTICS

**CURRENT SENSE VOLTAGE
vs
JUNCTION TEMPERATURE**

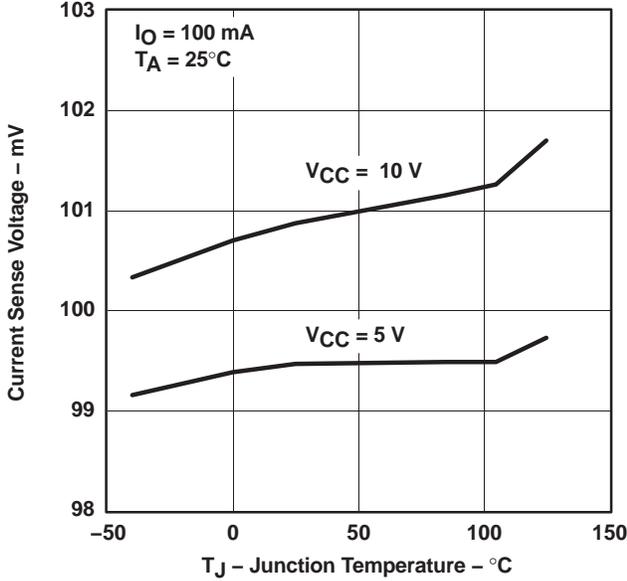


Figure 5

**QUIESCENT CURRENT
vs
INPUT VOLTAGE**

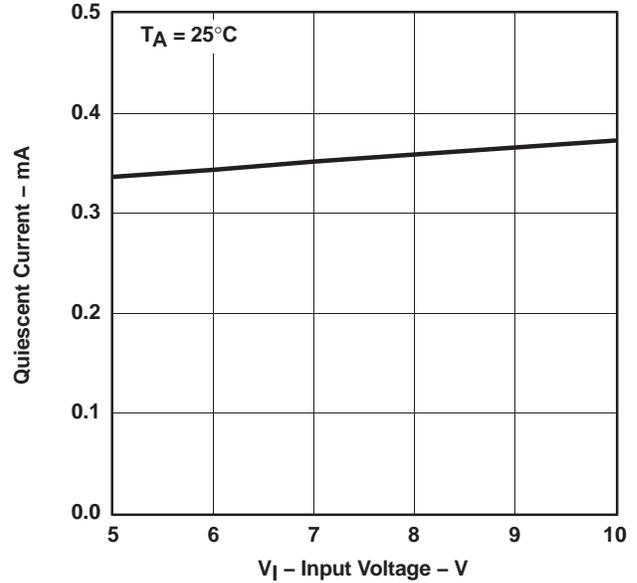


Figure 6

**QUIESCENT CURRENT
(POWER DOWN)
vs
INPUT VOLTAGE**

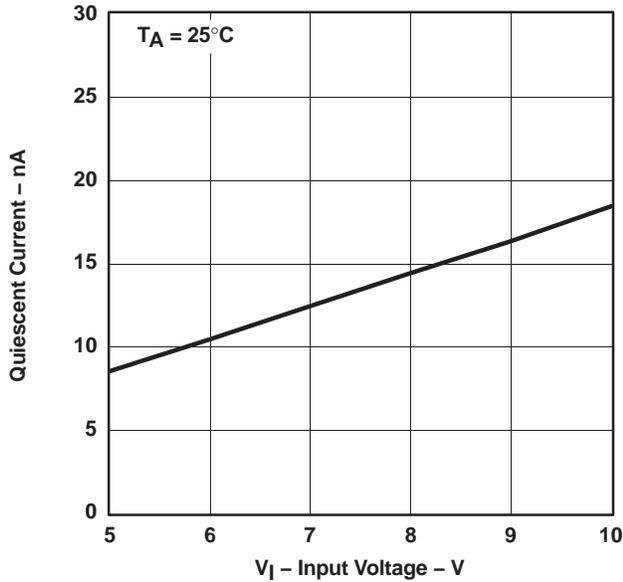


Figure 7

**DROPOUT VOLTAGE
vs
INPUT VOLTAGE**

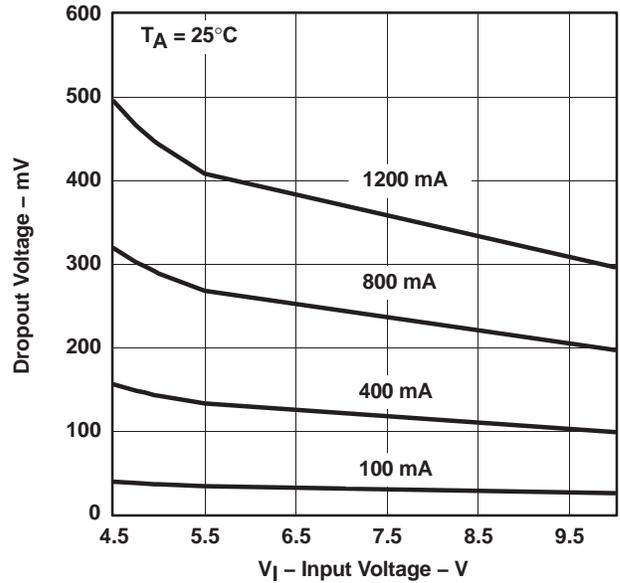


Figure 8

TYPICAL CHARACTERISTICS

DROPOUT VOLTAGE
vs
OUTPUT CURRENT

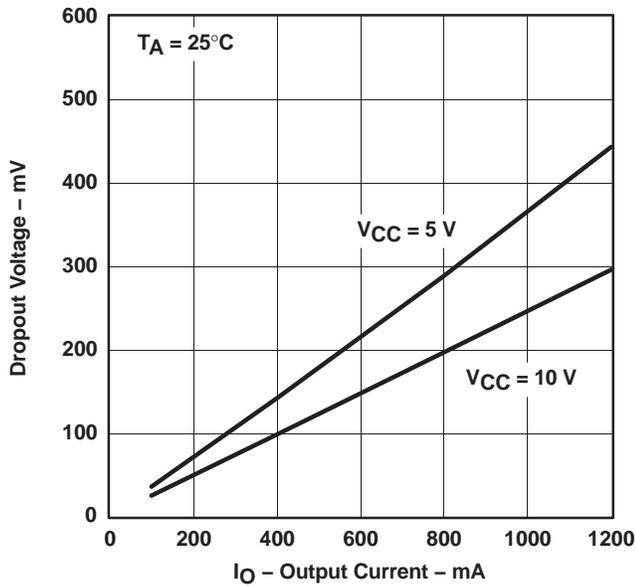


Figure 9

DROPOUT VOLTAGE
vs
JUNCTION TEMPERATURE

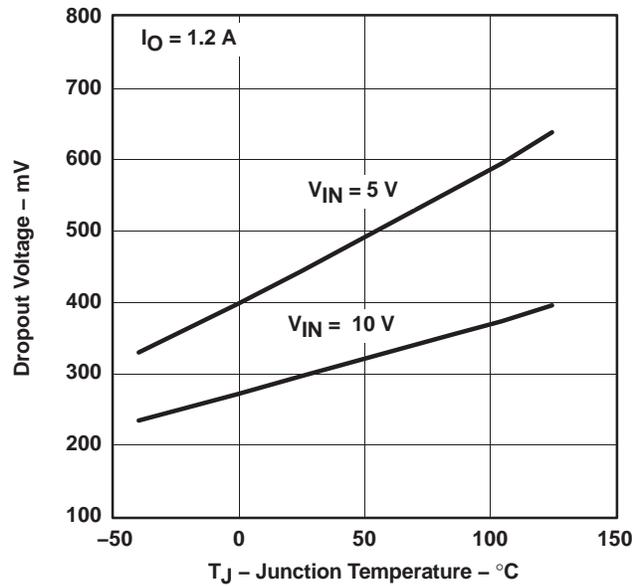


Figure 10

REVERSE CURRENT
vs
JUNCTION TEMPERATURE

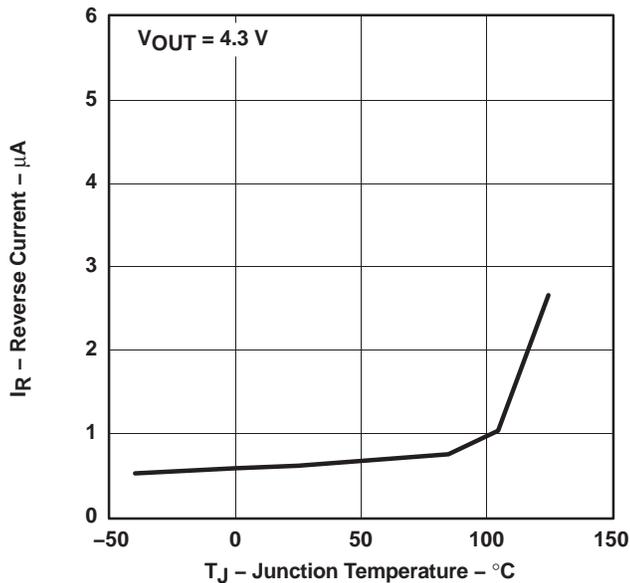


Figure 11

REVERSE CURRENT LEAKAGE
vs
VOLTAGE ON OUT PIN

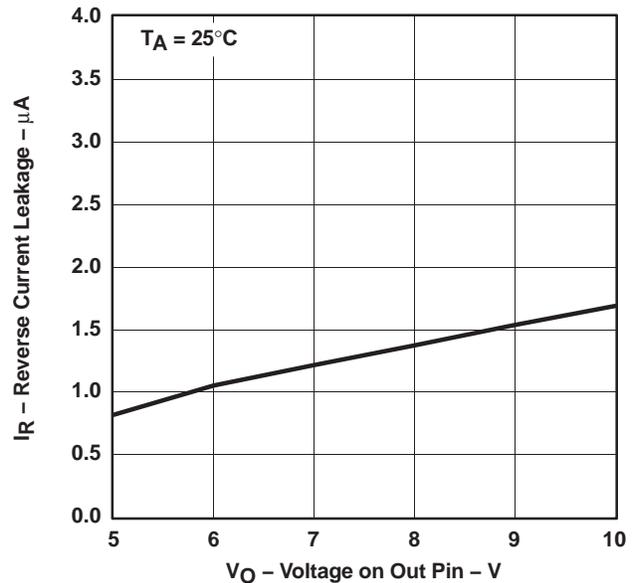


Figure 12

APPLICATION INFORMATION

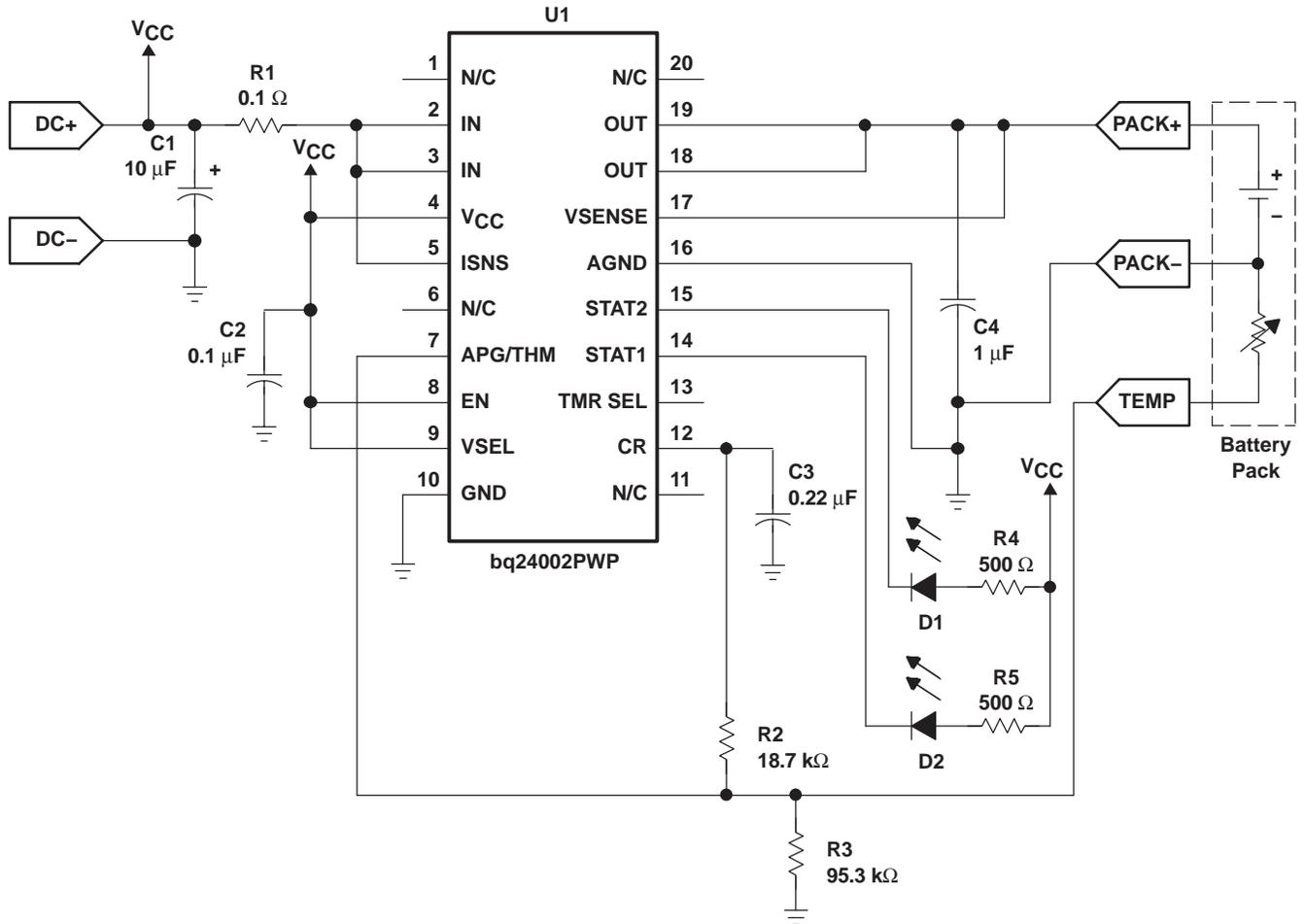


Figure 13. Li-Ion/Li-Pol Charger

- If the TMR SEL pin is left floating (3 HR time), a 10-pF capacitor should be installed between TMR SEL and CR.
- If a micro process is monitoring the STAT pins, it may be necessary to add some hysteresis into the feedback to prevent the STAT pins from cycling while crossing the taper detect threshold (usually less than one half second). See SLUU083 EVM or SLUU113 EVM for additional resistors used for the STAT pins.

APPLICATION INFORMATION

FUNCTIONAL DESCRIPTION

The bq2400x supports a precision current- and voltage-regulated Li-Ion charging system suitable for cells with either coke or graphite anodes. See Figure 14 for a typical charge profile and Figure 15 for an operational flowchart.

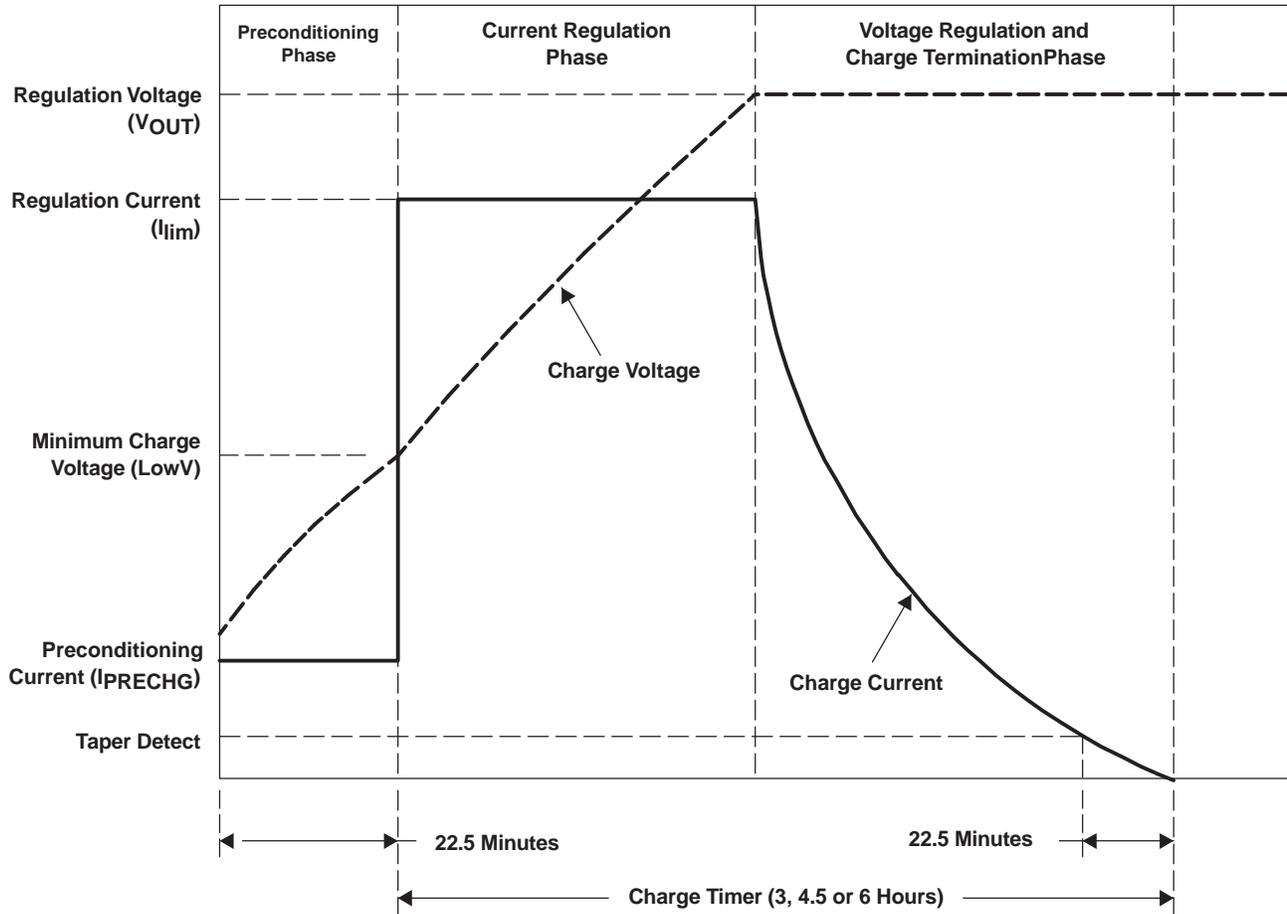


Figure 14. Typical Charge Profile

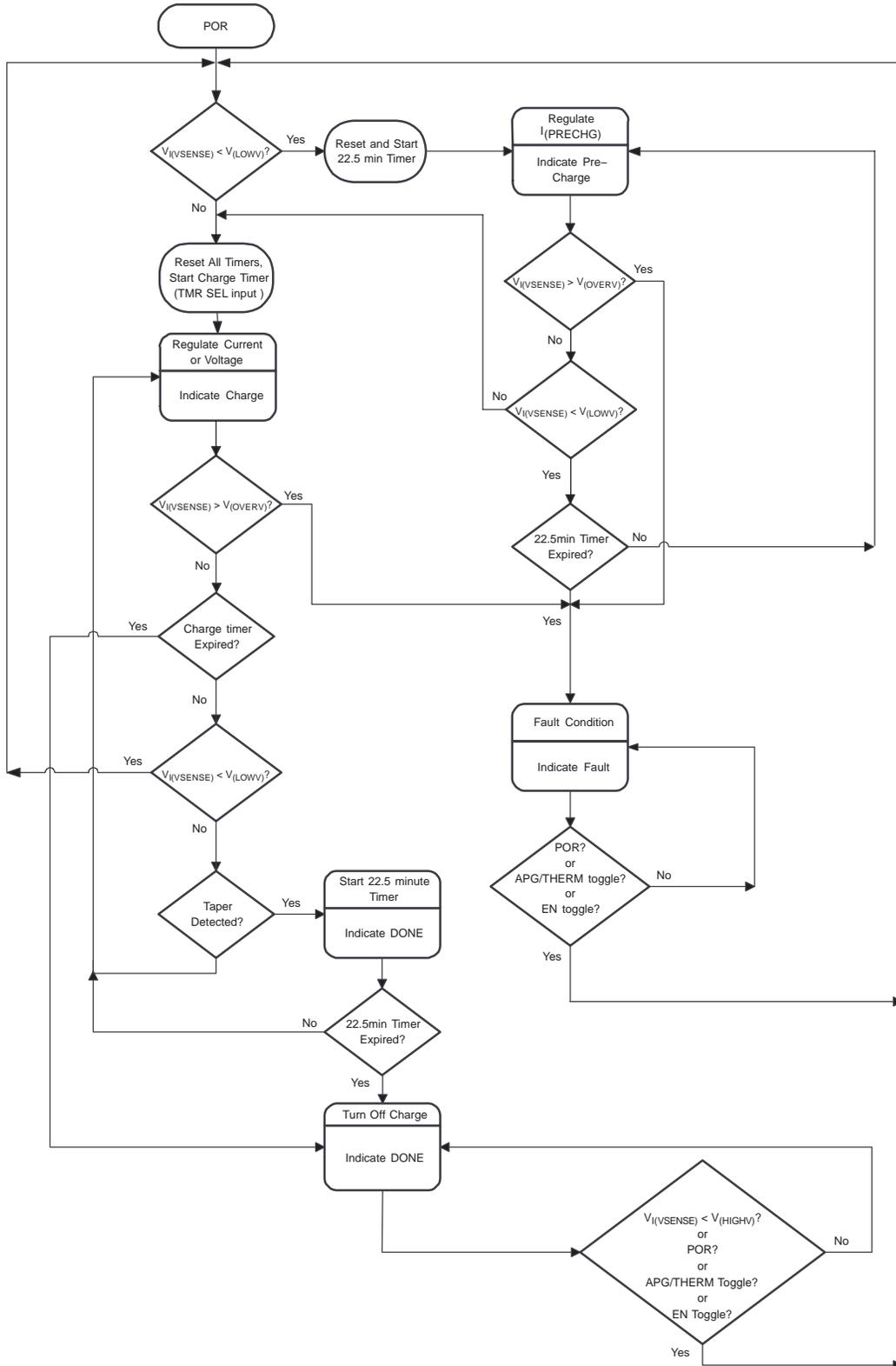


Figure 15. Operational Flow Chart

Charge Qualification and Preconditioning

The bq2400x starts a charge cycle when power is applied while a battery is present. Charge qualification is based on battery voltage and the APG/THERM input.

As shown in the block diagram, the internal LowV comparator output prevents fast-charging a deeply depleted battery. When set, charging current is provided by a dedicated precharge current source. The precharge timer limits the precharge duration. The precharge current also minimizes heat dissipation in the pass element during the initial stage of charge.

The APG/THERM input can also be configured to monitor

either the adapter power or the battery temperature using a thermistor. The bq2400x suspends charge if this input is outside the limits set by the user. Please refer to the APG/THERM input section for additional details.

APG/THERM Input

The bq400x continuously monitors temperature or system input voltage by measuring the voltage between the APG/THERM (adapter power good/thermistor) and GND. For temperature, a negative- or a positive- temperature coefficient thermistor (NTC, PTC) and an external voltage divider typically develop this voltage (see Figure 16). The bq2400x compares this voltage against its internal V_{TP1} and V_{TP2} thresholds to determine if charging is allowed. (See Figure 17.)

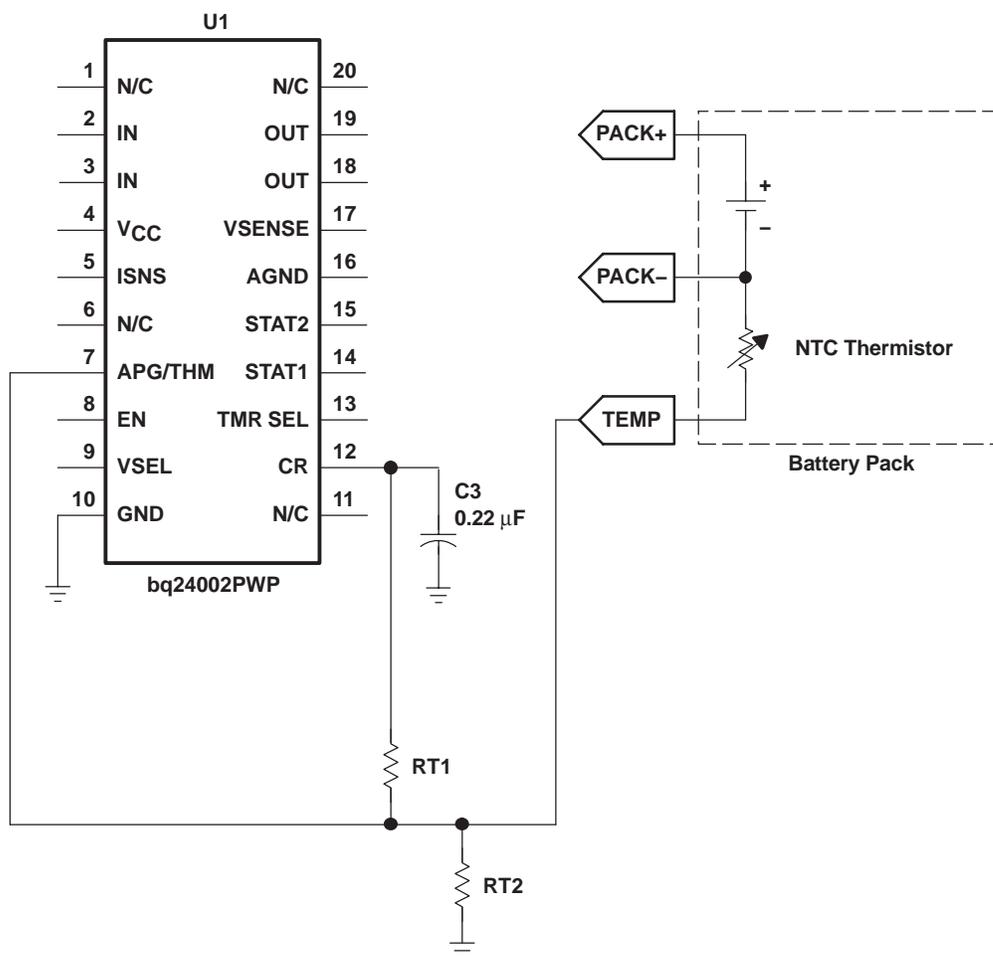


Figure 16. Temperature Sensing Circuit

If the charger designs incorporate a thermistor, the resistor divider RT1 and RT2 is calculated by using the following two equations.

First, calculate RT2.

$$RT2 = \frac{V_B R_H R_C \left[\frac{1}{V_C} - \frac{1}{V_H} \right]}{R_H \left(\frac{V_B}{V_H} - 1 \right) - R_C \left(\frac{V_B}{V_C} - 1 \right)}$$

then use the resistor value to find RT1.

$$RT1 = \frac{\frac{V_B}{V_C} - 1}{\frac{1}{RT2} + \frac{1}{R_C}}$$

Where:

$V_B = V_{CR}$ (bias voltage)

R_H = Resistance of the thermistor at the desired hot trip threshold

R_C = Resistance of the thermistor at the desired cold trip threshold

V_H = VP2 or the lower APG trip threshold

V_C = VP2 or the upper APG trip threshold

RT1 = Top resistor in the divider string

RT2 = Bottom resistor in the divider string

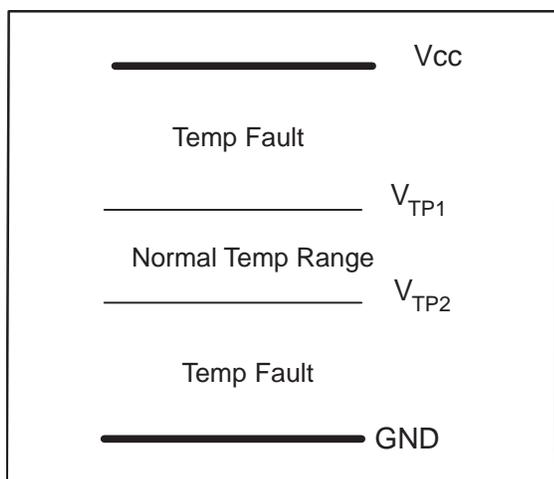


Figure 17. Temperature Threshold

Values of resistors R1 and R2 can be calculated using the following equation:

$$V_{APG} = V_{CC} \frac{R2}{(R1 + R2)}$$

where V_{APG} is the voltage at the APG/THM pin.

Current Regulation

The bq2400x provides current regulation while the battery-pack voltage is less than the regulation voltage. The current regulation loop effectively amplifies the error between a reference signal, V_{lim} , and the drop across the external sense resistor, R_{SNS} .

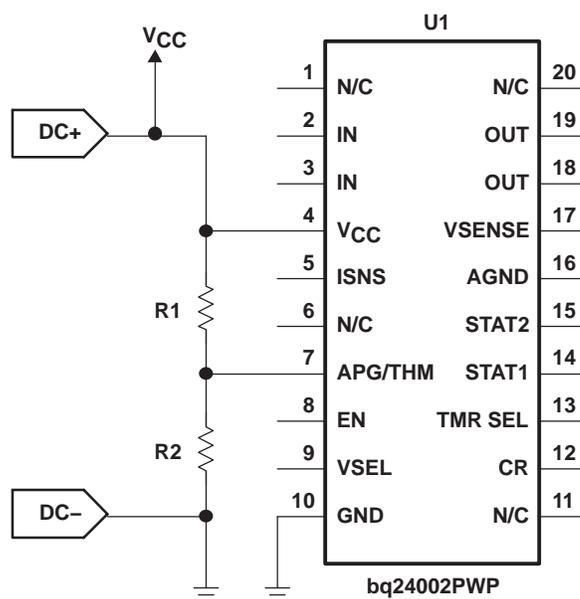


Figure 18. APG Sensing Circuit

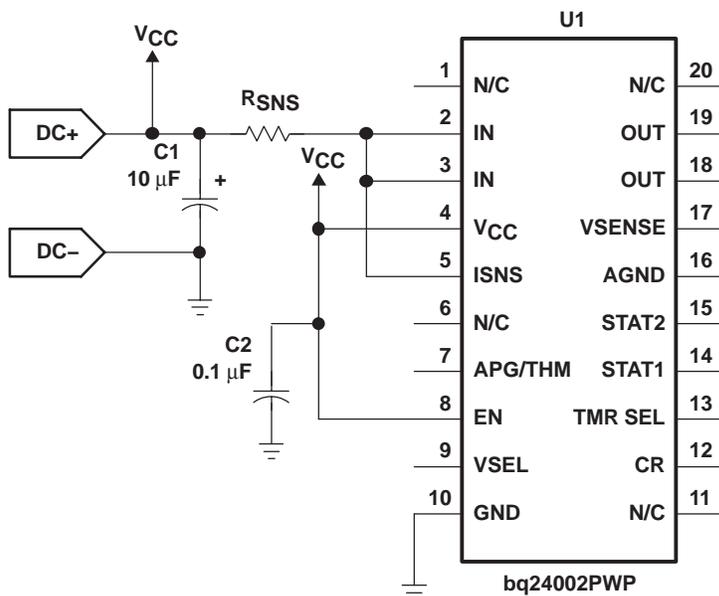


Figure 19. Current Sensing Circuit

Charge current feedback, applied through pin ISNS, maintains regulation around a threshold of V_{ilim} . The following formula calculates the value of the sense resistor:

$$R_{SNS} = \frac{V_{ilim}}{I_{REG}}$$

where I_{REG} is the desired charging current.

Voltage Monitoring and Regulation

Voltage regulation feedback is through pin VSENSE. This input is tied directly to the positive side of the battery pack. The bq2400x supports cells with either coke (4.1 V) or graphite (4.2 V) anode. Pin VSEL selects the charge regulation voltage.

VSEL State (see Note)	CHARGE REGULATION VOLTAGE
Low	4.1 V
High	4.2 V

NOTE: VSEL should not be left floating.

Charge Termination

The bq2400x continues with the charge cycle until termination by one of the two possible termination conditions:

Maximum Charge Time: The bq2400x sets the maximum charge time through pin TMRSEL. The TMR SEL pin allows the user to select between three different total charge-time timers (3, 4, 5, or 6 hours). The charge timer is initiated after the preconditioning phase of the charge and is reset at the beginning of a new charge cycle. Note

that in the case of a fault condition, such as an out-of-range signal on the APG/THERM input or a thermal shutdown, the bq2400x suspends the timer.

TMRSEL STATE	CHARGE TIME
Floating ⁽¹⁾	3 hours
Low	6 hours
High	4.5 hours

⁽¹⁾ To improve noise immunity, it is recommended that a minimum of 10 pF capacitor be tied to Vss on a floating pin.

Minimum Current: The bq2400x monitors the charging current during the voltage regulation phase. The bq2400x initiates a 22-minute timer once the current falls below the taperdet trip threshold. Fast charge is terminated once the 22-minute timer expires.

Charge Status Display

The three available options allow the user to configure the charge status display for single LED (bq24001), two individual LEDs (bq24002) or a bicolor LED (bq24003). The output stage is totem pole for the bq24001 and bq24003 and open-drain for the bq24002. The following tables summarize the operation of the three options:

Table 1. bq24001 (Single LED)

CHARGE STATE	STAT1
Precharge	ON (LOW)
Fast charge	ON (LOW)
FAULT	Flashing (1 Hz, 50% duty cycle)
Done (>90%)	OFF (HIGH)
Sleep-mode	OFF (HIGH)
APG/Therm invalid	OFF (HIGH)
Thermal shutdown	OFF (HIGH)
Battery absent	OFF (HIGH)

Table 2. bq24002 (2 Individual LEDs)

CHARGE STATE	STAT1 (RED)	STAT2 (GREEN)
Precharge	ON (LOW)	OFF
Fast charge	ON (LOW)	OFF
FAULT	Flashing (1 Hz, 50% duty cycle)	OFF
Done (>90%)	OFF	ON (LOW)
Sleep-mode	OFF	OFF
APG/Therm invalid	OFF	OFF
Thermal shutdown	OFF	OFF
Battery absent	OFF	OFF(1)

(1) If thermistor is used, then the Green LED is off.

Thermal Shutdown

The bq2400x monitors the junction temperature T_J of the DIE and suspends charging if T_J exceeds 165°C. Charging resumes when T_J falls below 155°C.

Table 3. bq24003 (Single Bicolor LED)

CHARGE STATE	LED1 (RED)	LED2 (GREEN)	APPARENT COLOR
Precharge	ON (LOW)	OFF (HIGH)	RED
Fast charge	ON (LOW)	OFF (HIGH)	RED
FAULT	ON (LOW)	ON (LOW)	YELLOW
Done (>90%)	OFF (HIGH)	ON (LOW)	GREEN
Sleep-mode	OFF (HIGH)	OFF (HIGH)	OFF
APG/Therm invalid	OFF (HIGH)	OFF (HIGH)	OFF
Thermal shutdown	OFF (HIGH)	OFF (HIGH)	OFF
Battery absent	OFF (HIGH)	OFF (HIGH)(1)	OFF(1)

(1) If thermistor is used, then the Green LED is off.

DETAILED DESCRIPTION

POWER FET

The integrated transistor is a P-channel MOSFET. The power FET features a reverse-blocking Schottky diode, which prevents current flow from OUT to IN.

An internal thermal-sense circuit shuts off the power FET when the junction temperature rises to approximately 165°C. Hysteresis is built into the thermal sense circuit. After the device has cooled approximately 10°C, the power FET turns back on. The power FET continues to cycle off and on until the fault is removed.

CURRENT SENSE

The bq2400x regulates current by sensing, on the ISNS pin, the voltage drop developed across an external sense resistor. The sense resistor must be placed between the supply voltage (V_{CC}) and the input of the IC (IN pins).

VOLTAGE SENSE

To achieve maximum voltage regulation accuracy, the bq2400x uses the feedback on the VSENSE pin. Externally, this pin should be connected as close to the battery cell terminals as possible. For additional safety, a 10kΩ internal pullup resistor is connected between the VSENSE and OUT pins.

ENABLE (EN)

The logic EN input is used to enable or disable the IC. A high-level signal on this pin enables the bq2400x. A low-level signal disables the IC and places the device in a low-power standby mode.

THERMAL INFORMATION

THERMALLY ENHANCED TSSOP-20

The thermally enhanced PWP package is based on the 20-pin TSSOP, but includes a thermal pad (see Figure 20) to provide an effective thermal contact between the IC and the PWB.

Traditionally, surface mount and power have been mutually exclusive terms. A variety of scaled-down TO220-type packages have leads formed as gull wings to make them applicable for surface-mount applications. These packages, however, suffer from several shortcomings: they do not address the very low profile requirements (<2 mm) of many of today's advanced systems, and they do not offer a pin-count high enough to accommodate increasing integration. On the other hand, traditional low-power surface-mount packages require power-dissipation derating that severely limits the usable range of many high-performance analog circuits.

The PWP package (thermally enhanced TSSOP) combines fine-pitch surface-mount technology with thermal performance comparable to much larger power packages.

The PWP package is designed to optimize the heat transfer to the PWB. Because of the very small size and limited mass of a TSSOP package, thermal enhancement is achieved by improving the thermal conduction paths that remove heat from the component. The thermal pad is formed using a lead-frame design (patent pending) and manufacturing technique to provide the user with direct connection to the heat-generating IC. When this pad is soldered or otherwise coupled to an external heat dissipator, high power dissipation in the ultrathin, fine-pitch, surface-mount package can be reliably achieved.

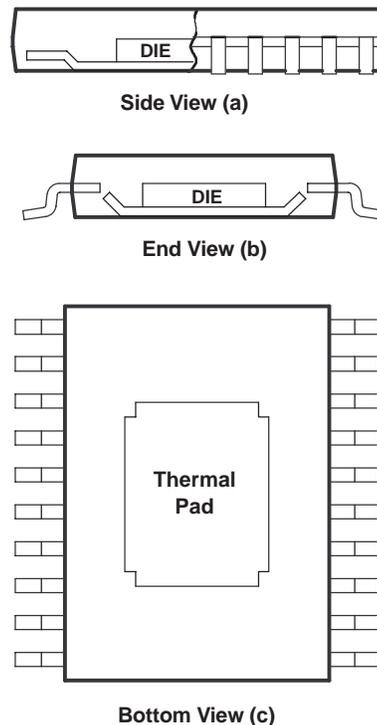


Figure 20. Views of Thermally Enhanced PWP Package

Because the conduction path has been enhanced, power-dissipation capability is determined by the thermal considerations in the PWB design. For example, simply adding a localized copper plane (heat-sink surface), which is coupled to the thermal pad, enables the PWP package to dissipate 2.5 W in free air. (Reference Figure 22(a), 8 cm² of copper heat sink and natural convection.) Increasing the heat-sink size increases the power dissipation range for the component. The power dissipation limit can be further improved by adding airflow to a PWB/IC assembly (see Figure 22(b) and 22(c)). The line drawn at 0.3 cm² in Figures 21 and 22 indicates performance at the minimum recommended heat-sink size.

THERMAL INFORMATION

THERMAL RESISTANCE
vs
COPPER HEAT-SINK AREA

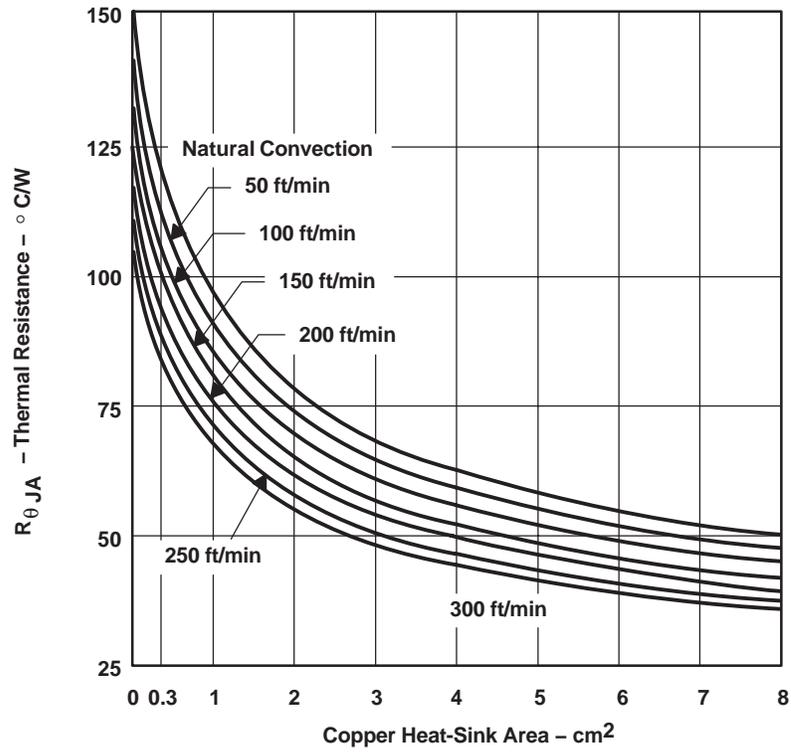
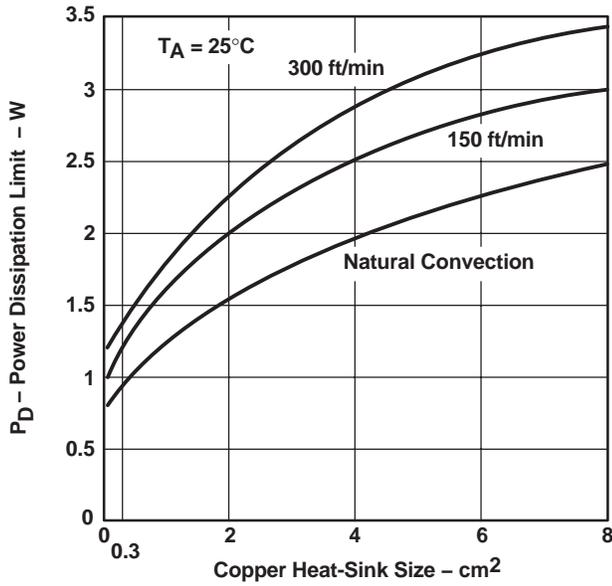
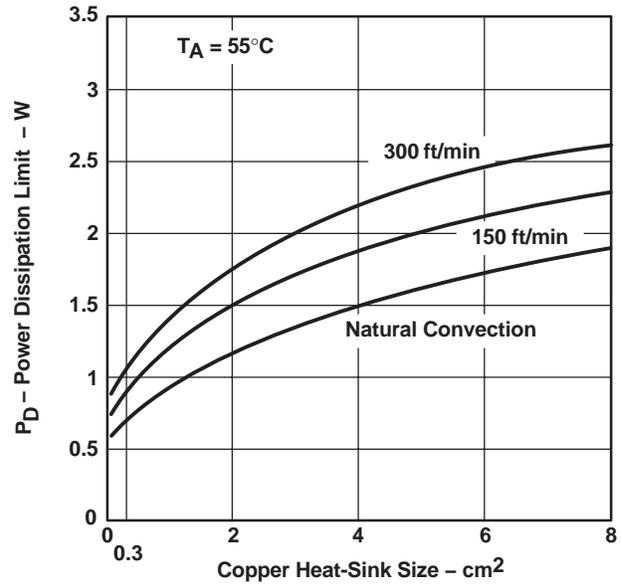


Figure 21

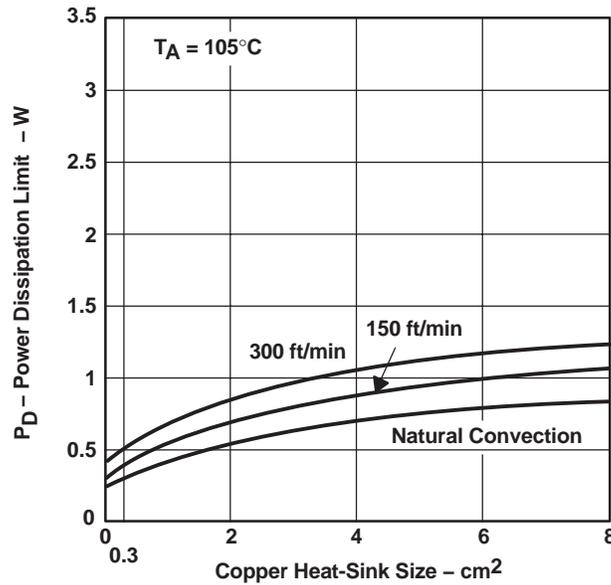
THERMAL INFORMATION



(a)



(b)



(c)

Figure 22. Power Ratings of the PWP Package at Ambient Temperatures of 25°C , 55°C , and 105°C

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
BQ24001PWP	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24001
BQ24001PWP.A	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24001
BQ24002PWP	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	BQ24002
BQ24002PWP.A	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	BQ24002
BQ24002PWPR	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	BQ24002
BQ24002PWPR.A	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	BQ24002
BQ24002RGWR	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	24002
BQ24002RGWR.A	Active	Production	VQFN (RGW) 20	3000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 0	24002
BQ24003PWP	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24003
BQ24003PWP.A	Active	Production	HTSSOP (PWP) 20	70 TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24003
BQ24003PWPR	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24003
BQ24003PWPR.A	Active	Production	HTSSOP (PWP) 20	2000 LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	0 to 70	BQ24003

(1) **Status:** For more details on status, see our [product life cycle](#).

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "-" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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TAPE AND REEL INFORMATION

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

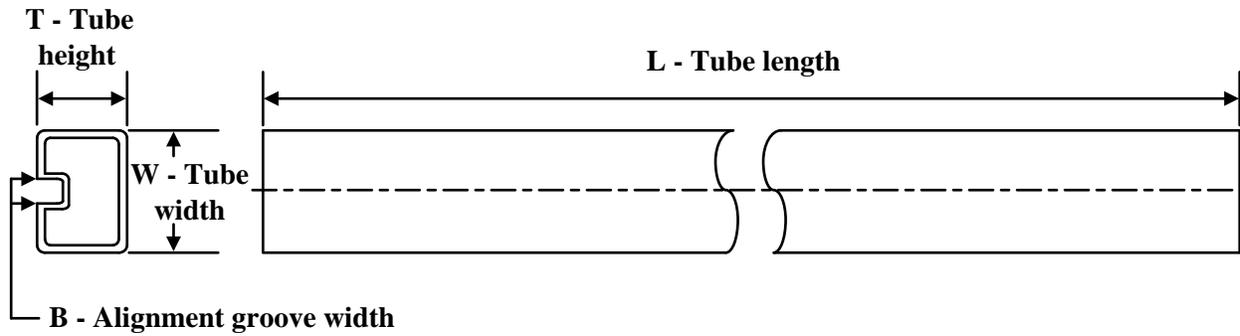

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ24002PWPR	HTSSOP	PWP	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
BQ24002RGWR	VQFN	RGW	20	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2
BQ24003PWPR	HTSSOP	PWP	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1

TAPE AND REEL BOX DIMENSIONS


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ24002PWPR	HTSSOP	PWP	20	2000	350.0	350.0	43.0
BQ24002RGWR	VQFN	RGW	20	3000	353.0	353.0	32.0
BQ24003PWPR	HTSSOP	PWP	20	2000	350.0	350.0	43.0

TUBE


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
BQ24001PWP	PWP	HTSSOP	20	70	530	10.2	3600	3.5
BQ24001PWP.A	PWP	HTSSOP	20	70	530	10.2	3600	3.5
BQ24002PWP	PWP	HTSSOP	20	70	530	10.2	3600	3.5
BQ24002PWP.A	PWP	HTSSOP	20	70	530	10.2	3600	3.5
BQ24003PWP	PWP	HTSSOP	20	70	530	10.2	3600	3.5
BQ24003PWP.A	PWP	HTSSOP	20	70	530	10.2	3600	3.5

GENERIC PACKAGE VIEW

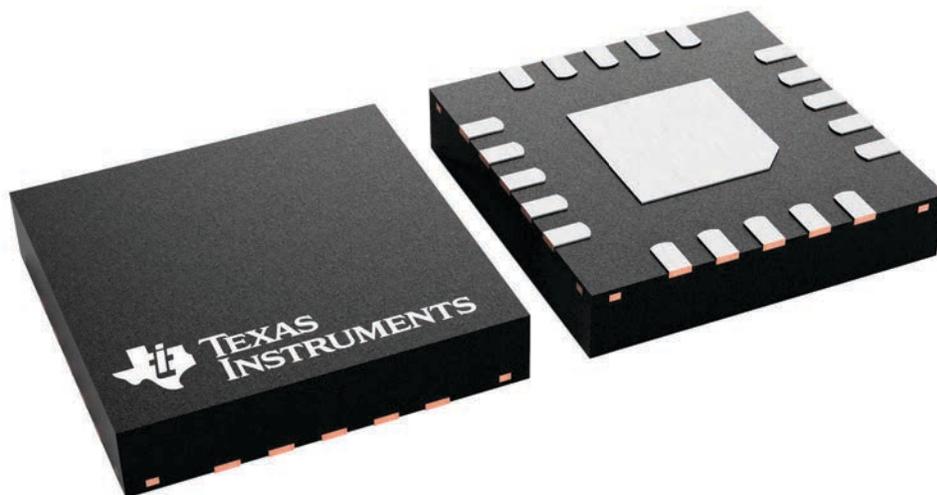
RGW 20

VQFN - 1 mm max height

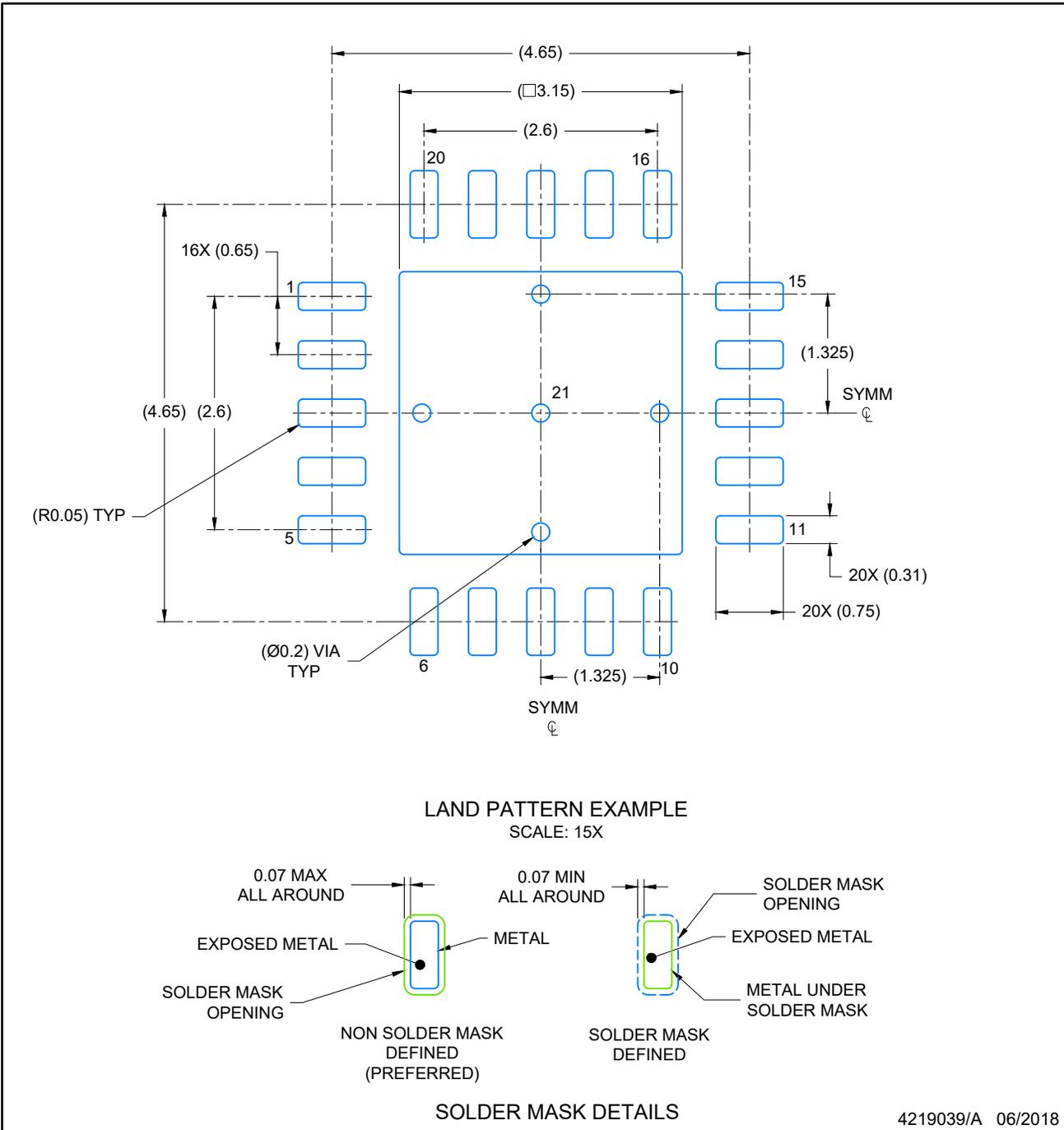
5 x 5, 0.65 mm pitch

PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4227157/A



NOTES: (continued)

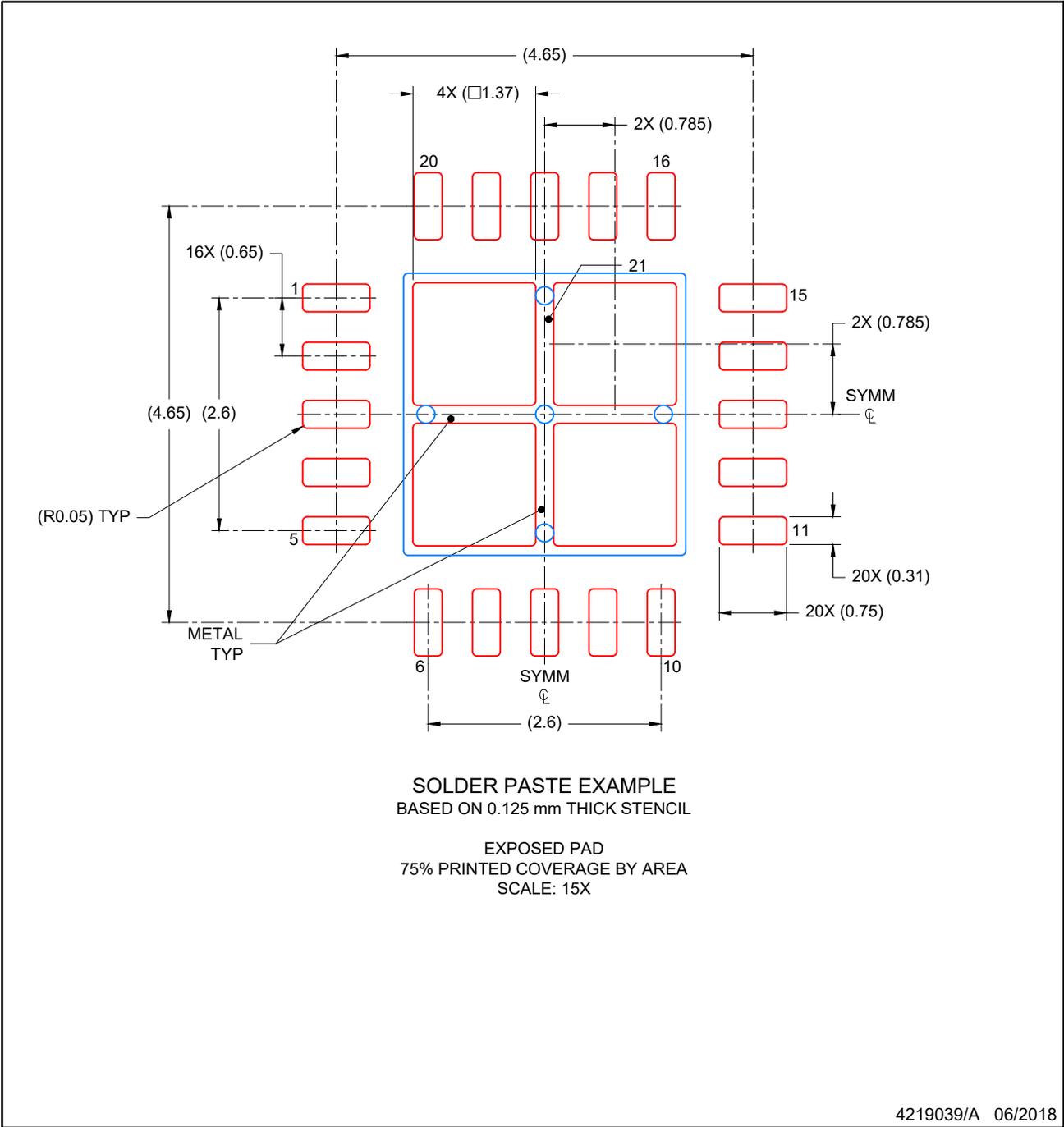
4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/sluea271).
5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

VQFN - 1 mm max height

RGW0020A

PLASTIC QUAD FLATPACK-NO LEAD



NOTES: (continued)

- 6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

GENERIC PACKAGE VIEW

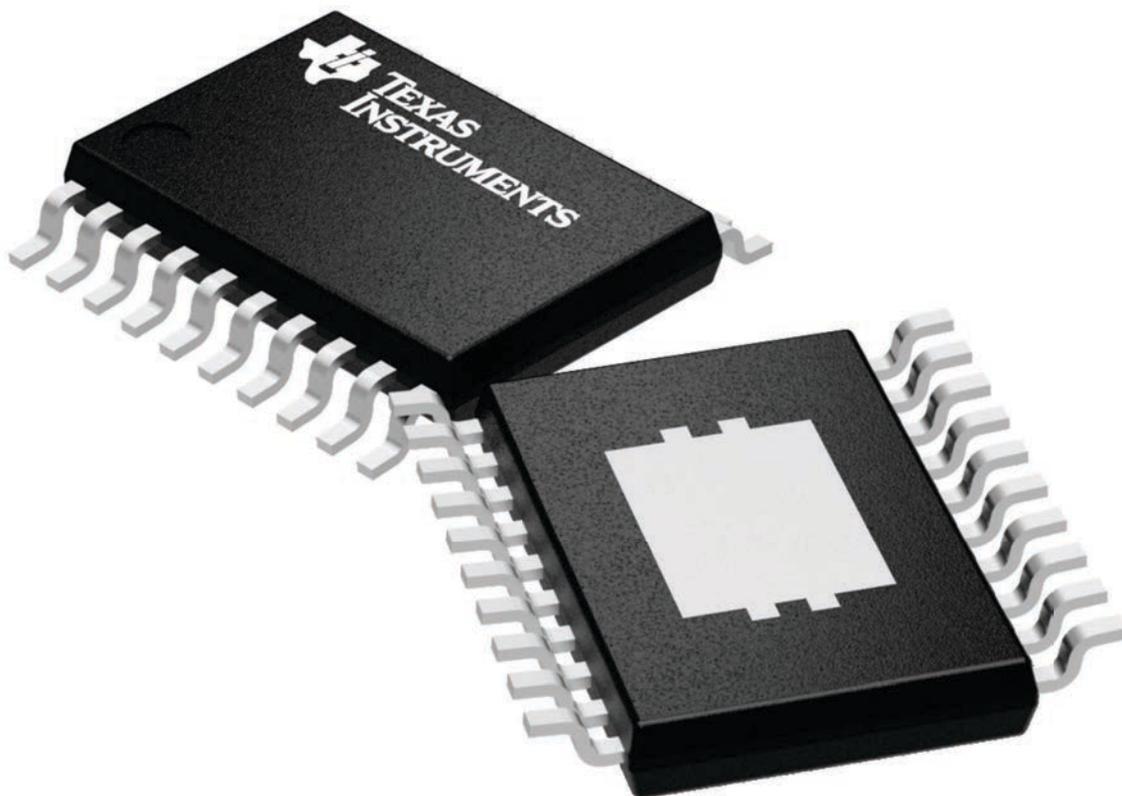
PWP 20

HTSSOP - 1.2 mm max height

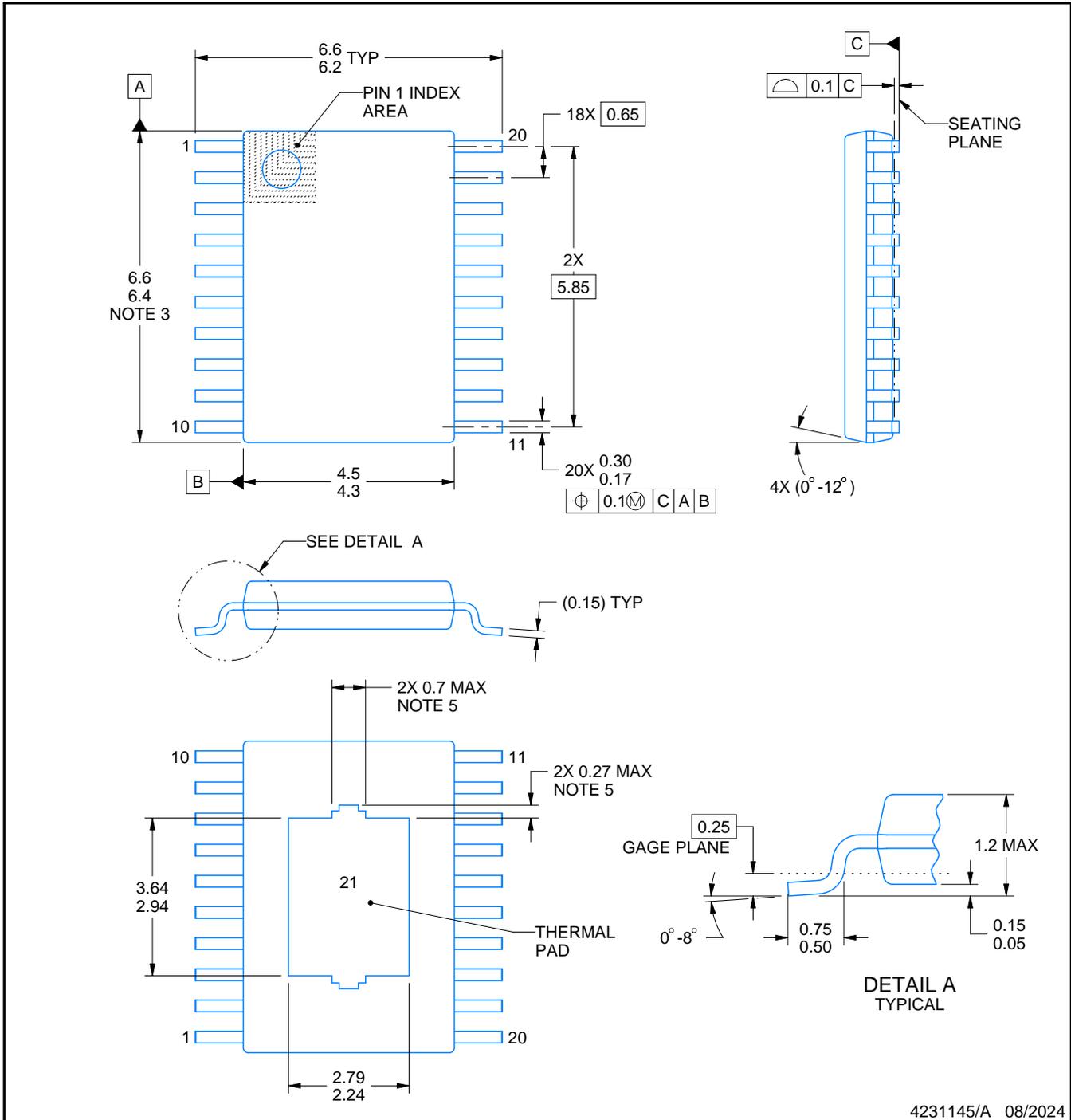
6.5 x 4.4, 0.65 mm pitch

SMALL OUTLINE PACKAGE

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4224669/A



PowerPAD is a trademark of Texas Instruments.

NOTES:

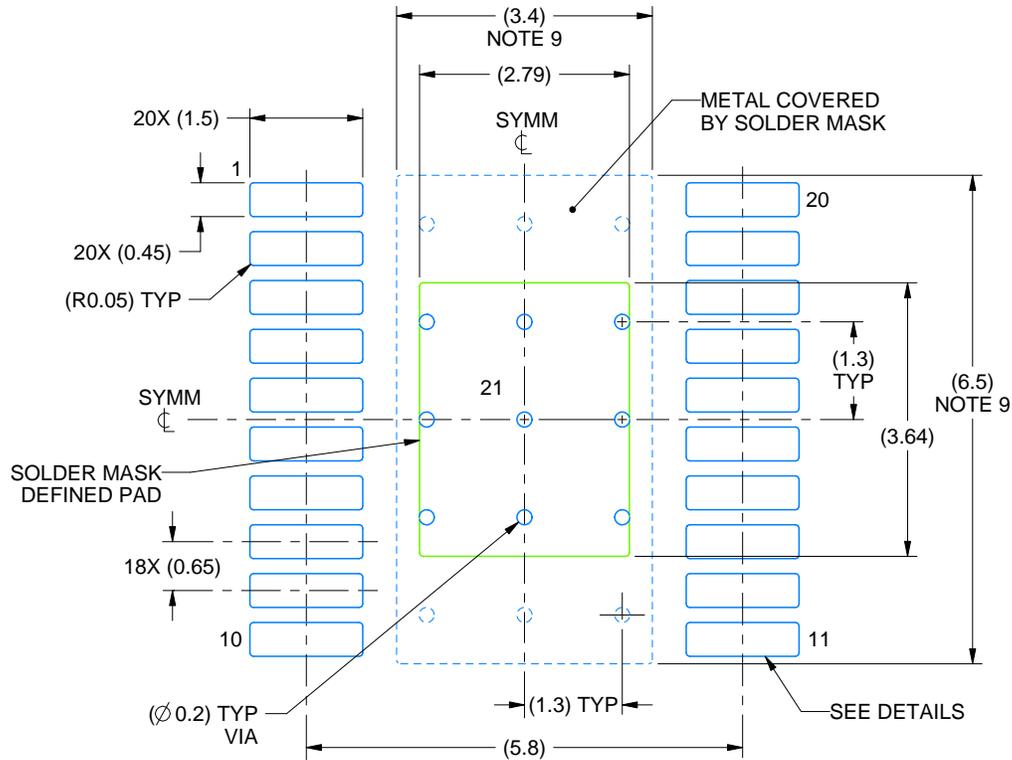
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. Reference JEDEC registration MO-153.
5. Features may differ or may not be present.

EXAMPLE BOARD LAYOUT

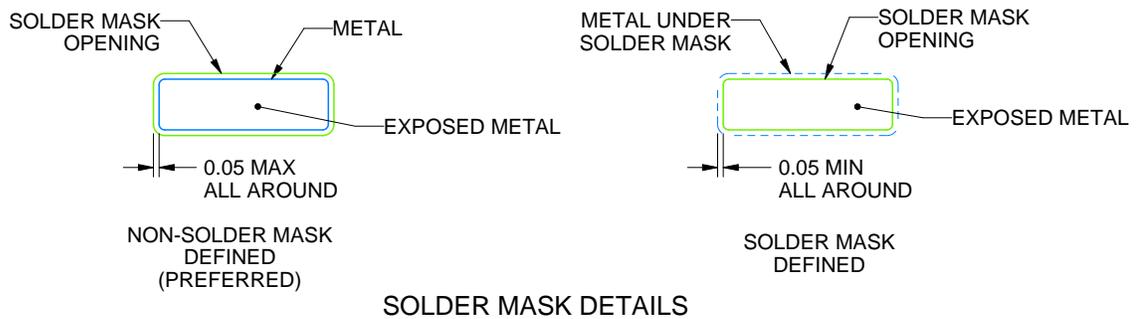
PWP0020W

PowerPAD™ TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X



4231145/A 08/2024

NOTES: (continued)

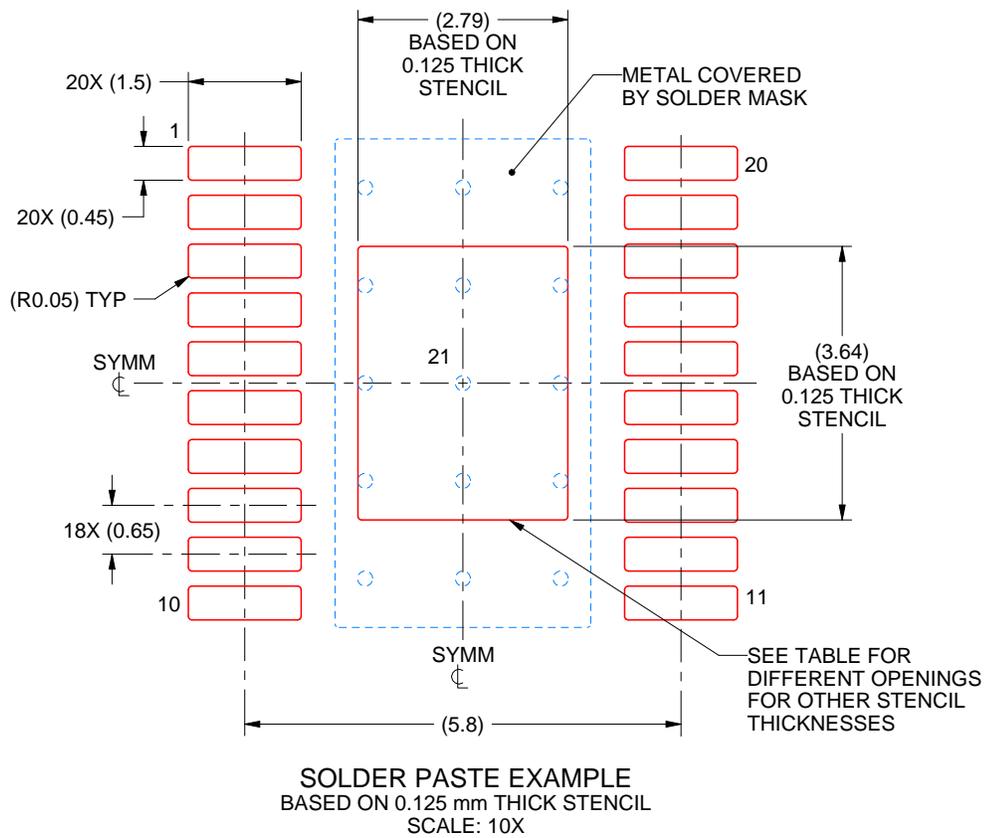
6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature numbers SLMA002 (www.ti.com/lit/slma002) and SLMA004 (www.ti.com/lit/slma004).
9. Size of metal pad may vary due to creepage requirement.
10. Vias are optional depending on application, refer to device data sheet. It is recommended that vias under paste be filled, plugged or tented.

EXAMPLE STENCIL DESIGN

PWP0020W

PowerPAD™ TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



STENCIL THICKNESS	SOLDER STENCIL OPENING
0.1	3.12 X 4.07
0.125	2.79 X 3.64 (SHOWN)
0.15	2.55 X 3.32
0.175	2.36 X 3.08

4231145/A 08/2024

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.

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